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APPLICATION NO. CONT/PRIOR CLASS/ SUBCLASS ART UNIT EXAMINER 2873 2877 09/816164 5.bck mith

Hiroshi Nomura

Method of measuring displacement of optical axis, optical microscope and evaluation mark

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ISSUING CLASSIFICATION								
ORIGINAL	CROSS REFERENCE(S)							
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
INTERNATIONAL CLASSIFICATION								
	4	Continued on Issue Slip Inside File Jacket						

TERMINAL	DRAWINGS			CLAIMS ALLOWED		
DISCLAIMER	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.	
The term of this patent subsequent to (date)	3			NOTICE OF ALI	LOWANCE MAILED	
has been disclaimed.	(Assistant Exeminer)		(Date)			
The term of this patent shall not extend beyond the expiration date of U.S Patent. No.	• .		·	. ISS	UE FEE	
				Amount Due	Date Paid	
	(Primary E	xaminer)	(Date)			
The terminal—months of this patent have been disclaimed.	·		ISSUE BATCH NUMBER			
uns patent have been discialmed.	(Legal Instrume	ents Examiner)	(Date)			
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